



TF90LVDS048 / TF90LVDT048

Quad LVDS Line Receivers with Extended Common Mode

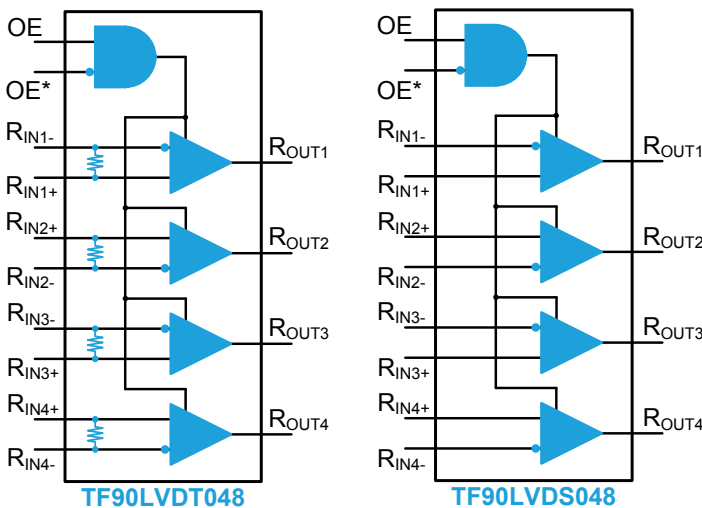
Features

- **Extended input common mode voltage range: -7V to 12V**
- **DC to 400 Mbps / 200 MHz low noise, low skew, low power operation**
 - ◆ 500 ps (max) channel-to-channel skew
 - ◆ 350 ps (max) pulse skew
 - ◆ 7 mA (max) power supply current
- **Flow-through pinout eases PCB layout and reduces crosstalk**
- **On-chip 100Ω input termination minimizes return loss, component count and board space (TF90LVDT048)**
- **Classic pull-up/down resistor fail-safe(TF90LVDS048)**
- **LVDS inputs conform to TIA/EIA-644-A standard**
- **Standard output enable scheme eliminates power consumption when device is not in use**
- **Guaranteed operation within industrial temperature range -40° to +85°C**
- **Available in space saving SOIC-16 and TSSOP-16 packages**
- **TF90LVDS048 pin and function compatible with NSC DS90LV048A and TI SN65LVDS048A, SN65LVDS348, TF90LVDT048 with TI SN65LVDT348**

Applications

- Digital Copiers
- Wireless Base Stations
- Telecom / Datacom
- Network Routing
- Laser Printers
- LCD Displays

Function Diagrams



Description

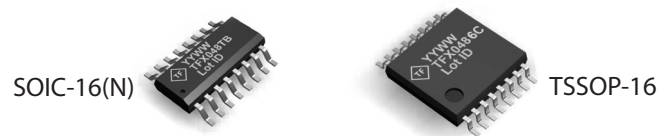
The TF90LVDS048 and TF90LVDT048 are 400 Mbps Quad LVDS (low voltage differential signaling) Line Receivers optimized for high-speed, low power, low noise transmission over controlled impedance (approximately 100Ω) transmission media (e.g. cables, printed circuit board traces, backplanes).

The TF90LVDS048 and TF90LVDT048 input receivers support wide input voltage range of -7V to 12V for exceptional noise immunity.

The TF90LVDS048 and TF90LVDT048 accept four LVDS signals and translate them to four LVCMOS signals. The outputs can be disabled and put in a high-impedance state via two enable pins, OE and OE*. The flow-through pinout simplifies PCB layout and minimizes crosstalk by isolating the LVDS inputs from the LVCMOS / LVTTTL outputs.

The TF90LVDT048 features on-chip 100Ω input termination resistors that minimize input return loss, component count and board space. The TF90LVDS048 differential inputs are without input termination resistors and are suitable for applications requiring custom termination schemes.

Supply current is 7 mA (max). LVDS inputs conform to the ANSI/EIA/TIA-644-A standard. The TF90LVDS048 and TF90LVDT048 are offered in 16-pin SOIC and TSSOP packages and operate over an extended -40 °C to +85 °C temperature range.

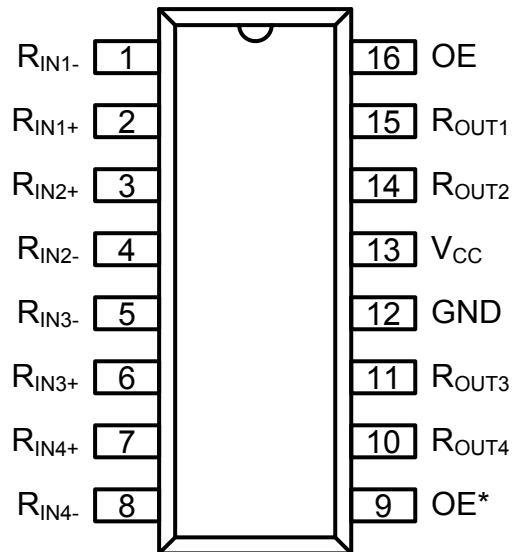


Ordering Information

PART NUMBER	PACKAGE	PACK / Qty	Year		Week	
			Year	Week	Year	Week
TF90LVDS048-TBU	SOIC-16	Tube / 48	YY	WW	TF	XX
TF90LVDS048-TBG	SOIC-16	T&R / 500				
TF90LVDT048-6CU	TSSOP-16	Tube / 94	YY	WW	TF	XX
TF90LVDT048-6CG	TSSOP-16	T&R / 1000				

Replace X with S for No Termination, or T for Termination.

Pin Diagram



SOIC-16 or TSSOP-16

Logic Table

OE	OE*	$R_{IN+} - R_{IN-}$	R_{OUT}
1	0 or open	≥ 100 mV	H
		≤ -100 mV	L
		Failsafe condition	H
Any other combination		Don't Care	Disabled

Table 1. Output Enables Truth Table

Pin Descriptions

PIN NAME	PIN NUMBER	PIN TYPE	PIN DESCRIPTION
R_{IN1+} R_{IN1-} R_{IN2+} R_{IN2-} R_{IN3+} R_{IN3-} R_{IN4+} R_{IN4-}	2, 1, 3, 4, 6, 5, 7, 8	LVDS inputs	Non-inverting and inverting LVDS receiver input pins.
R_{OUT1} R_{OUT2} R_{OUT3} R_{OUT4}	15, 14, 11, 10	LVC MOS outputs	Receiver LVC MOS output pins.
OE, OE*	16, 9	LVC MOS inputs	Receiver output enable pins. Both, OE and OE* pins have internal pull-down devices. When OE is high and OE* is low or open, the receiver outputs are enabled. For all other combinations of OE and OE*, the receiver outputs are disabled.
V_{CC}	13	Power	Power supply pin. decouple V_{CC} to GND with 0.1 μ F and 0.01 μ F ceramic capacitors.
GND	12	Ground	Ground or circuit common pin.

Quad LVDS Line Receivers with Extended Common Mode

Absolute Maximum Ratings¹

V_{CC} to GND.....-0.3V to +4V

Inputs

OE, OE* to GND.....-0.3V to V_{CC} + 0.3V

R_{IN+} R_{IN-} to GND.....-7.5V to +12.5V

V_{ID} (R_{IN+} to R_{IN-}).....-6V to +6V (LVDT -2V to +2V)

Outputs

R_{OUT} to GND.....-0.3V to V_{CC} + 0.3V

Maximum Package Power Dissipation ($T_A = +25\text{ °C}$)

SOIC-16 (derate 13.8 mW/°C above +25 °C).....1.7 W

TSSOP-16 (derate 9.7 mW/°C above +25 °C).....1.2W

SOIC-16 Thermal Resistance

θ_{JC}41 °C/W

θ_{JA}72 °C/W

TSSOP-16 Thermal Resistance

θ_{JC}29 °C/W

θ_{JA}103 °C/W

Storage Temperature Range-65°C to +150°C

Maximum Junction Temperature+150°C

Lead Temperature (soldering, 4s)+260°C

ESD Ratings

HBM¹.....8 kV

MM².....250V

¹ Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

¹ Human Body Model, applicable standard JESD22-A114-C

² Machine Model, applicable standard JESD22-A115-A

Recommended Operating Conditions

Symbol	Parameter	Pins	MIN	TYP	MAX	Unit
V_{CC}	Supply Voltage	V_{CC}	3	3.3	3.6	V
V_{IH}	High-level input voltage	OE, OE*	2		V_{CC}	V
V_{IL}	Low-level input voltage	OE, OE*	0		0.8	V
V_{ID}	Differential input voltage	R_{IN+} R_{IN-}	0.1	0.35	1	V
V_{IN}	Input voltage	R_{IN+} R_{IN-}	-7		12	V
T_A	Operating free-air temperature	All	-40	25	85	°C

Electrical Characteristics

Over recommended operating conditions (**NOTE1**), unless otherwise specified. Typical values are $V_{CC} = 3.3V$, $T_A = 25^\circ C$.

Symbol	Parameter	Conditions	MIN	TYP	MAX	Unit	
LVCMOS Input Specifications (OE, OE* pins)							
V_{IH}	High-level input voltage		2.0		V_{CC}	V	
V_{IL}	Low-level input voltage		GND		0.8	V	
I_{IH}	High-level input current	$V_{CC} = 3.6V$ $V_{IN} = 3.6V$	-10	2	10	μA	
I_{IL}	Low-level input current	$V_{CC} = 0$ or $3.6V$ $V_{IN} = 0V$	-10	0	10	μA	
V_{CL}	Input clamp voltage (NOTE 4)	$I_{CL} = -18$ mA, $V_{CC} = 0V$	-1.5	-0.9		V	
LVCMOS Output Specifications (R_{OUT} pins)							
V_{OH}	Output high voltage	$I_{OH} = -0.4$ mA, $V_{ID} = 200$ mV	2.7	3.2		V	
		$I_{OH} = -0.4$ mA, input open	2.7	3.2		V	
V_{OL}	Output low voltage	$I_{OL} = 2$ mA, $V_{ID} = -200$ mV		0.05	0.25	V	
I_{OS}	Output short circuit current (NOTE 2)	Enabled, $V_{OUT} = 0V$		-50	-100	mA	
I_{OZ}	Output High-Z current	Disabled, $V_{OUT} = 0V$ or V_{CC}	-10		10	μA	
LVDS Input Specifications (R_{IN+}, R_{IN-} pins)							
V_{TH}	Differential input high threshold	$V_{ICM} = -7.0V$ to $12.0V$ (NOTE 3)		0	100	mV	
V_{TL}	Differential input low threshold		-100	0		mV	
V_{ID}	Differential input voltage		0.1	0.35	1	V	
V_{ICM}	Input common mode voltage	$V_{ID} = 100$ mV	-6.95		11.95	V	
I_{IN}	Input current $V_{CC} = 0$ or $3.6V$	TF90LVDS048	$0V \leq V_{IN+} \leq 2.4V$, $V_{IN-} = 1.2V$	-22		22	μA
			$-4V \leq V_{IN+} \leq 6.4V$, $V_{IN-} = \text{open}$	-60		65	μA
			$-7V \leq V_{IN+} \leq 12V$, $V_{IN-} = \text{open}$	-110		175	μA
		TF90LVDT048	$0V \leq V_{IN+} \leq 2.4V$, $V_{IN-} = \text{open}$	-45		45	μA
			$-4V \leq V_{IN+} \leq 6.4V$, $V_{IN-} = \text{open}$	-130		130	μA
			$-7V \leq V_{IN+} \leq 12V$, $V_{IN-} = \text{open}$	-220		350	μA
C_{IN}	Input capacitance	R_{IN+} or R_{IN-} to GND		4		pF	
R_{IN}	Input termination resistor	TF90LVDT048 only		100		Ω	

NOTE1 Current into device pin is defined as positive. Current out of the device is defined as negative. All voltages are referenced to ground, unless otherwise specified.

NOTE2 Output short circuit current (I_{OS}) is specified as magnitude only. The minus sign indicates direction only. Only one output should be shorted at a time, do not exceed maximum junction temperature specification. Specified for momentary short condition durations only.

NOTE3 Recommended operating conditions for the R_{IN+} and R_{IN-} pins is over the range of $-7.0V$ to $12.0V$. Therefore, caution should be taken not to exceed these values or the maximum Differential Input voltage of $1.0V$.

NOTE4 This specification is not production tested and is guaranteed by design simulations.

Electrical Characteristics (Continued)

Over recommended operating conditions (**NOTE1**), unless otherwise specified. Typical values are $V_{CC} = 3.3V$, $T_A = 25^\circ C$.

Power Supply Current Specifications						
I_{CC}	Power supply current	All outputs enabled and not switching.		5	7	mA
I_{CCZ}	Power supply current with disabled outputs	All outputs disabled.		1	2	mA

Switching Characteristics

Over recommended operating conditions, unless otherwise specified. Typical values are at $V_{CC} = 3.3V$, $T_A = 25^\circ C$.

Symbol	Parameter	Conditions	MIN	TYP	MAX	Unit
AC Specifications (NOTES 5, 6, and 7)						
t_{PLH}	Propagation delay, low-to-high	Figures 1 and 2 $C_L = 15pF$ $V_{ID} = 200mV$ $V_{CM} = 1.2V$ (NOTE12)	1.2	2.0	3.2	ns
t_{PHL}	Propagation delay, high-to-low		1.2	2.0	3.2	ns
t_r	Rise time		0.35	1.0	ns	
t_f	Fall time		0.3	1.0	ns	
$t_{SK(p)}$	Pulse skew (NOTE8)		100	350	ps	
$t_{SK(c-c)}$	Channel-to-channel skew (NOTE9)		100	500	ps	
$t_{SK(p-p)}$	Part-to-part skew (Note 10)			1.5	ns	
t_{PLZ}	Disable time, low-to-high Z	Figures 3 and 4 $R_L = 2K\Omega$ $C_L = 15pF$ $V_{ID} = 200mV$ $V_{CM} = 1.2V$ (NOTE12)		8	14	ns
t_{PHZ}	Disable time, high-to-high Z			8	14	ns
t_{PZL}	Enable time, high Z-to-low			8	14	ns
t_{PZH}	Enable time, high Z-to-high			8	14	ns
f_{MAX}	Maximum operating frequency (NOTES 11 and 12)	$C_L = 15pF$ Figure 1	200	250		MHz

NOTE5 Generator output characteristics (unless otherwise specified): $f = 1 MHz$, $Z_0 = 50\Omega$, $t_r < 1 ns$, $t_f < 1 ns$.

NOTE6 All input voltages are for one channel unless otherwise specified. Other inputs are set to GND

NOTE7 Switching Characteristic specification are not production tested and are guaranteed by statistical analysis of characterization data.

NOTE8 $t_{SK(p)}$ pulse skew, is the magnitude difference in propagation delay time between the positive going edge and the negative going edge of the same channel ($t_{SK(p)} = |t_{PLH} - t_{PHL}|$).

NOTE9 $t_{SK(c-c)}$ channel-to-channel skew, is the difference in propagation delay time between channels with any edges (HL and LH) on the same device at any operating temperature and supply voltage.

NOTE10 $t_{SK(p-p)}$ part-to-part skew is the difference in propagation delay time between devices with any edges (HL and LH) operating at the same power supply voltage and within $5^\circ C$ of each other within the operating temperature range.

NOTE11 f_{MAX} generator input conditions: $t_r = t_f < 1ns$ (0% to 100%), 50% duty cycle, differential (1.05V to 1.35V peak to peak). Output Criteria: 60%/40% duty cycle, VOL (max 0.4V), VOH (min 2.7V),

NOTE12 The capacitive load C_L includes test fixture, probe and lumped capacitance.

Test Circuits and Timing Diagrams

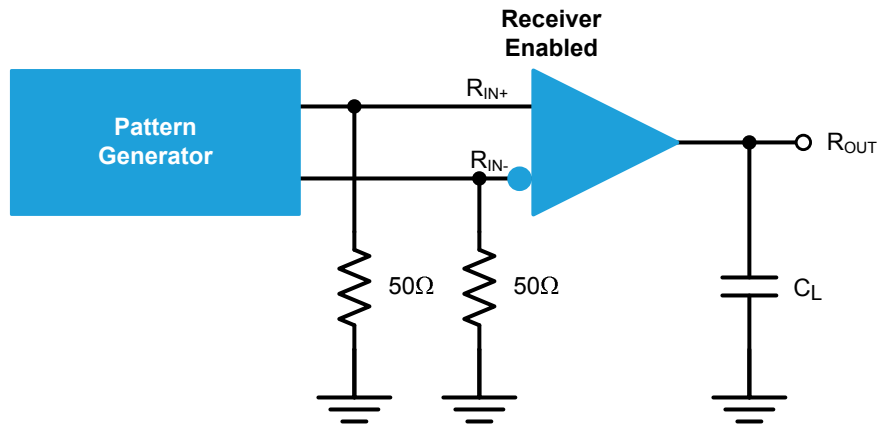


Figure 1. Receiver Propagation Delay and Transition Time Test Setup

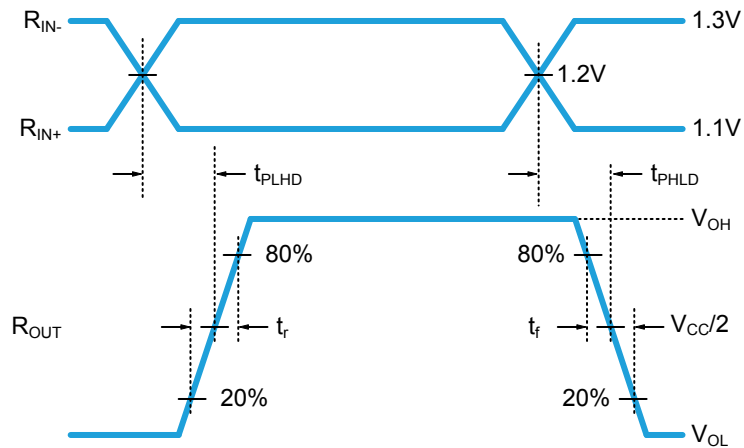


Figure 2. Receiver Propagation Delay and Transition Time Waveforms

Test Circuits and
Timing Diagrams

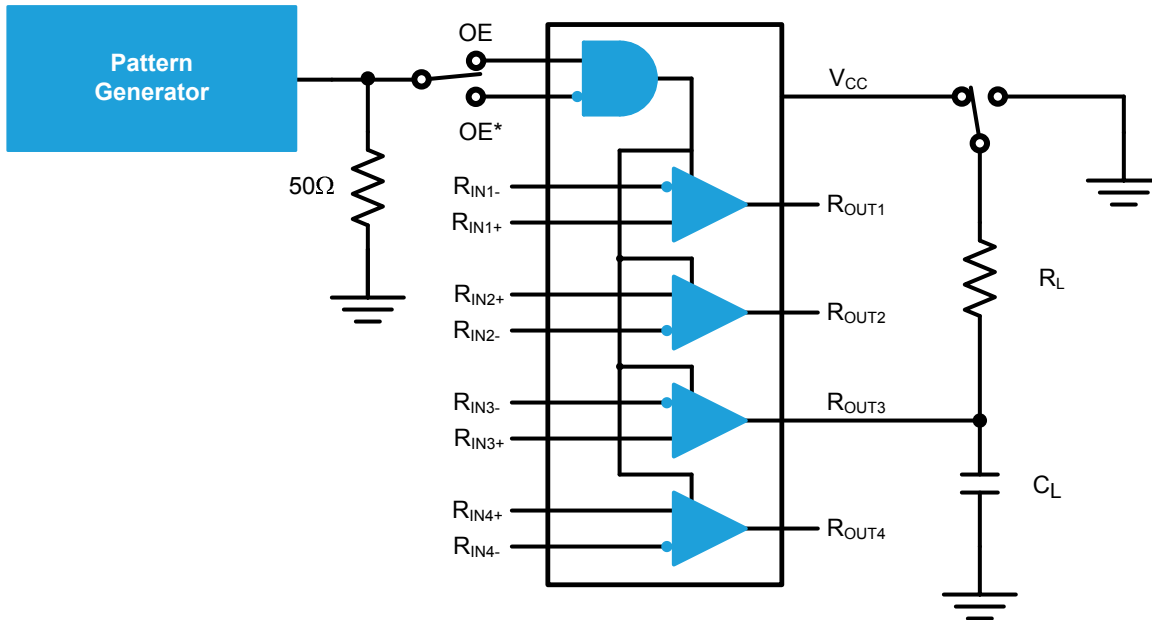


Figure 3. Receiver High-Z Delay Test Setup

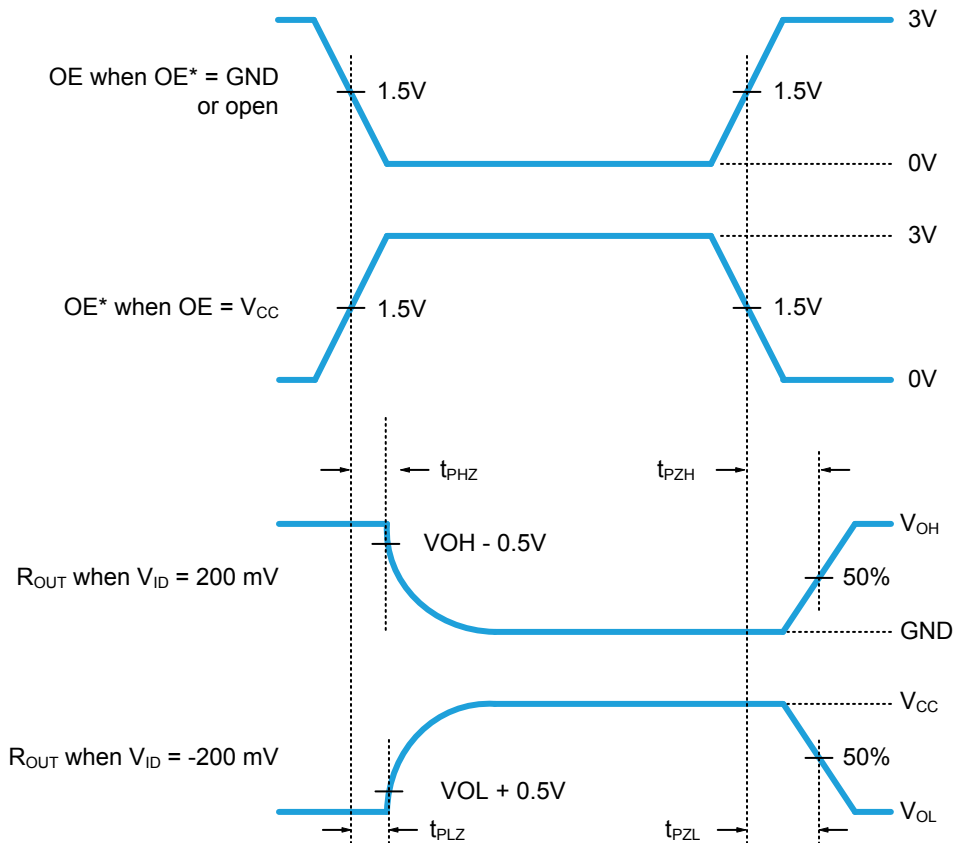
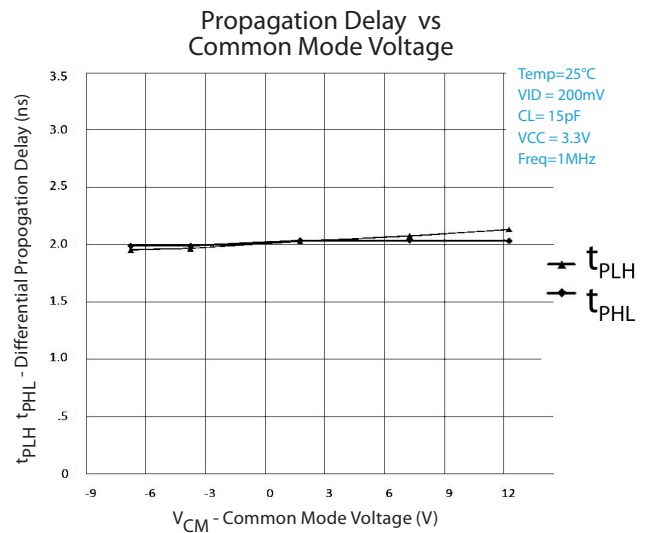
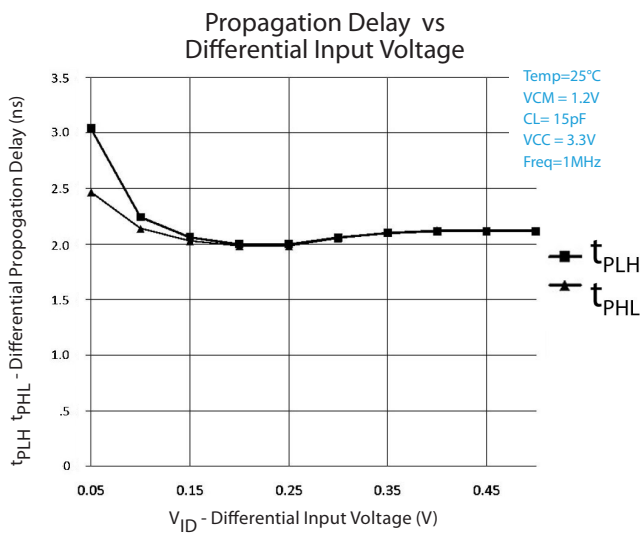
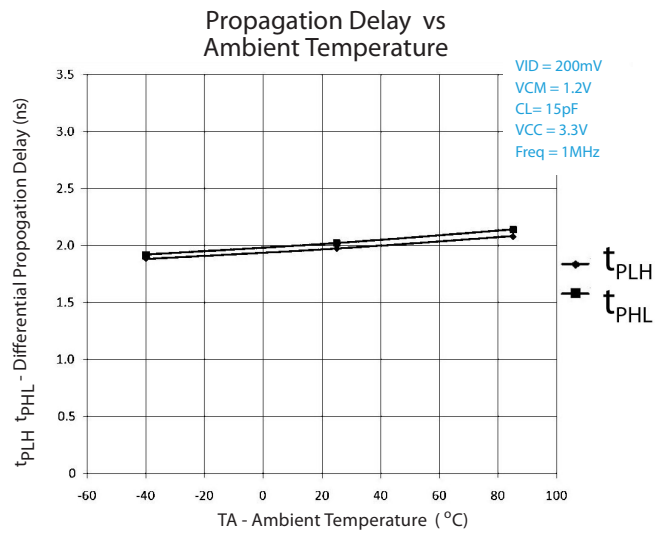
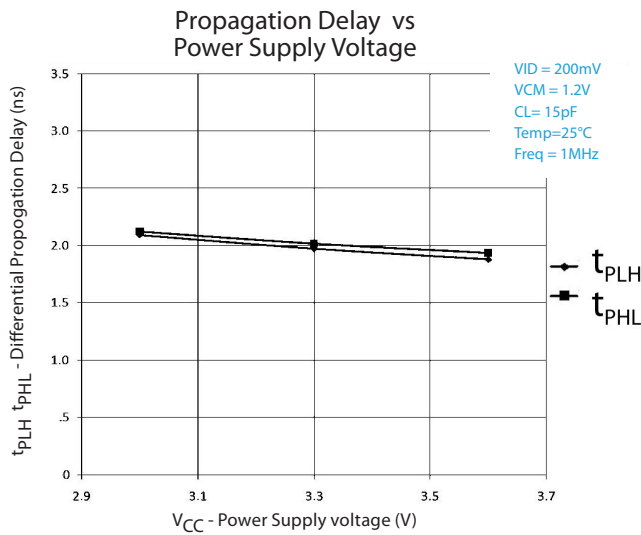
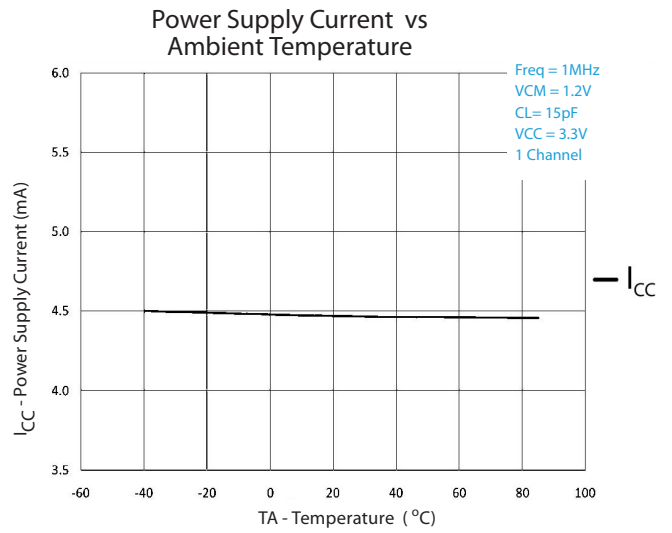
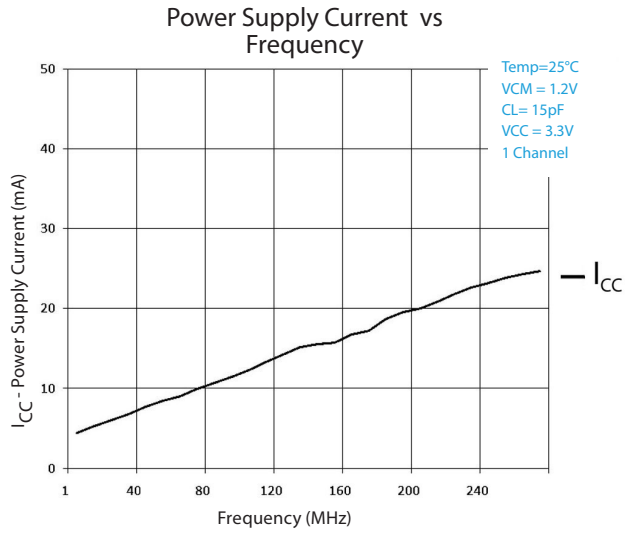
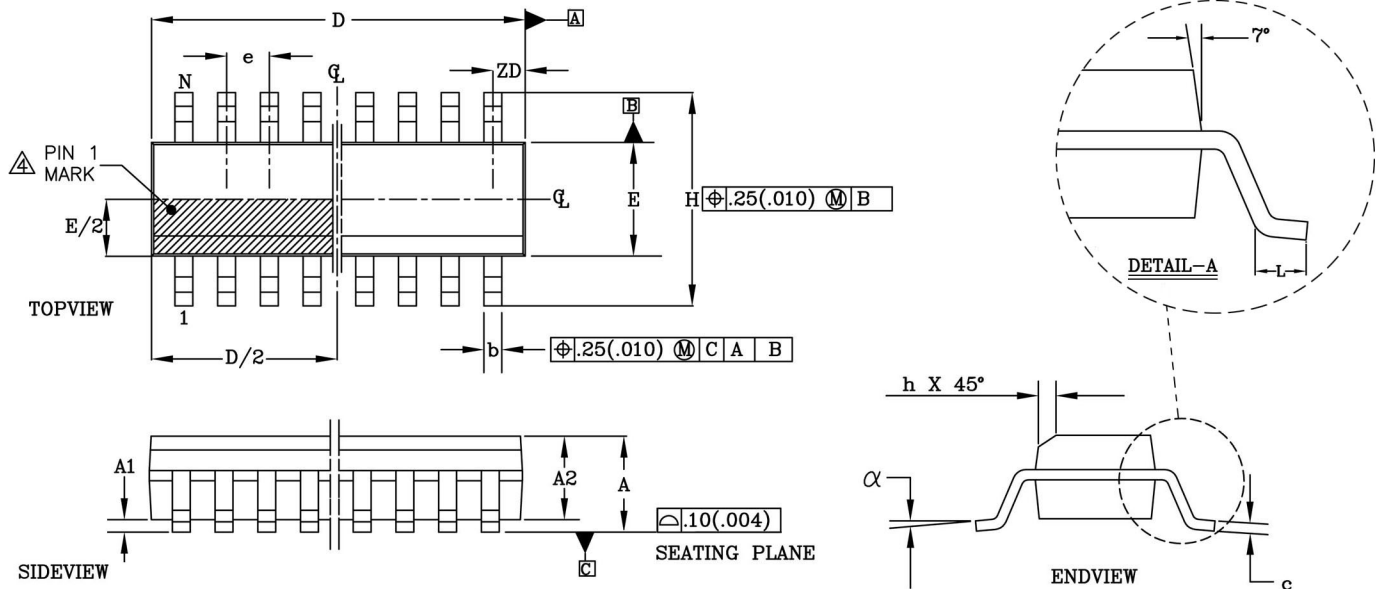


Figure 4. Receiver High-Z Delay Waveform

Typical Performance Curves



SOIC-16 Package Dimensions


SYMBOL	SOIC-16LD	
	MILLIMETERS	
	MIN	MAX
A1	0.10	0.25
B	0.36	0.46
C	0.19	0.25
D	9.80	9.98
E	3.81	3.99
e	1.27 BSC	
H	5.80	6.20
h	0.25	0.50
L	0.41	1.27
A	1.52	1.72
α	0°	8°
ZD	0.51	REF
A2	1.37	1.57

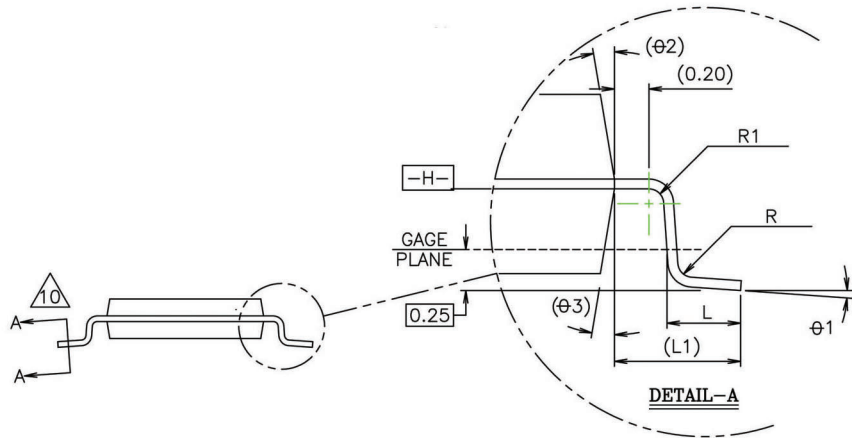
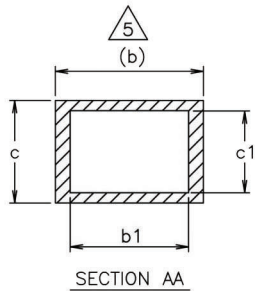
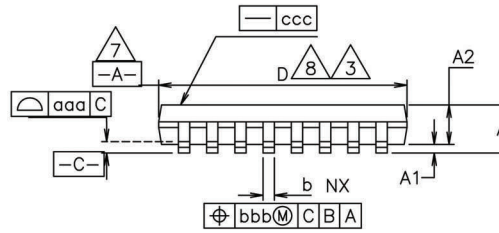
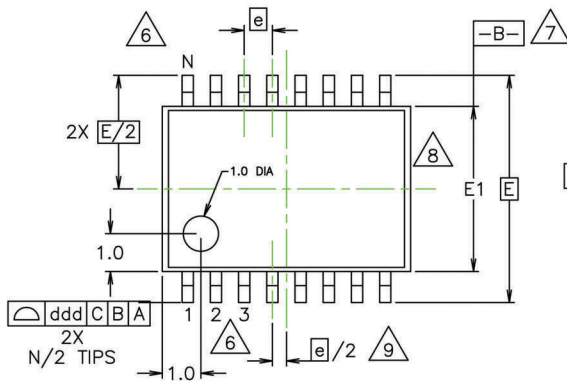
SYMBOL	SOIC-16LD	
	INCHES	
	MIN	MAX
A1	.0040	.0098
B	.014	.018
C	.0075	.0098
D	.386	.393
E	.150	.157
e	.050 BSC	
H	.2284	.2440
h	.0099	.0196
L	.016	.050
A	.060	.068
α	0°	8°
ZD	.020	REF
A2	.054	.062

NOTES :

- LEAD COPLANARITY SHOULD BE 0 TO 0.10MM (.004") MAX.
- PACKAGE SURFACE FINISHING :
(2.1) TOP : MATTE (CHARMILLES #18~30).
- ALL DIMENSIONS EXCLUDING MOLD FLASHES AND END FLASH FROM THE PACKAGE BODY SHALL NOT EXCEED 0.25MM (.010") PER SIDE(D).

Δ DETAIL OF PIN #1 IDENTIFIER ARE OPTIONAL BUT MUST BE LOCATED WITHIN THE ZONE INDICATED.

TSSOP-16 Package Dimensions (Please contact support@telefunkensemi.com for availability)



	0.65mm LEAD PITCH			NOTE
	MIN	NOM	MAX	
A	---	---	1.10	---
A1	0.05	---	0.15	---
A2	0.85	0.90	0.95	---
L	0.50	0.60	0.75	---
R	0.09	---	---	---
R1	0.09	---	---	---
b	0.19	---	0.30	5
b1	0.19	0.22	0.25	---
c	0.09	---	0.20	---
c1	0.09	---	0.16	---
theta1	0°	---	8°	---
L1	1.0 REF			---
aaa	0.10			---
bbb	0.10			---
ccc	0.05			---
ddd	0.20			---
e	0.65 BSC			---
theta2	12° REF			---
theta3	12° REF			---
NOTE	1,2			---
D	4.90	5.00	5.10	---
E1	4.30	4.40	4.50	---
E	6.4 BSC			---
e	0.65 BSC			---
N	16			---

- NOTES:
- ALL DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
 - DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
 - DIMENSION 'D' DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE.
 - DIMENSION 'E1' DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 PER SIDE.
 - DIMENSION 'b' DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 MM TOTAL IN EXCESS OF THE 'b' DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD IS 0.07 MM FOR 0.5 MM PITCH PACKAGES.
 - TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
 - DATUMS \square -A- AND \square -B- TO BE DETERMINED AT DATUM PLANE \square -H-
 - DIMENSIONS 'D' AND 'E1' ARE TO BE DETERMINED AT DATUM PLANE \square -H-
 - THIS DIMENSION APPLIES ONLY TO VARIATIONS WITH AN EVEN NUMBER OF LEADS PER SIDE. FOR VARIATION WITH AN ODD NUMBER OF LEADS PER SIDE, THE "CENTER" LEAD MUST BE COINCIDENT WITH THE PACKAGE CENTERLINE, DATUM A.
 - CROSS SECTION A-A TO BE DETERMINED AT 0.10 TO 0.25 MM FROM THE LEAD TIP.
 - THIS VARIATION IS NOT REGISTERED WITH JEDEC.
 - PACKAGE SURFACE FINISHING:
 - TOP: MATTE (CHARMILLES: #18~30)
 - BOTTOM: MATTE (CHARMILLES: #12~27)

Notes

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